

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

America Amaranta Siller Compian / Mediciones y Proyectos Industriales MEPI

Nueva 264, Col. El Mirador Ramos Arizpe, Coahuila, México. C.P. 25902

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Dimensional, Mechanical, Mass, Force and Weighing Devices, Optical, Time and Frequency, Electrical and Thermodynamic Calibration
(As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Tracy Szerszen

President

Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084 Initial Accreditation Date: Issue Date: Expiration Date:

June 13, 2022 June 13, 2022 September 30, 2024

Revision Date: Accreditation No.: Certificate No.:

June 23, 2023 115763 L22-432-R1

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: www.pjlabs.com



America Amaranta Siller Compian / Mediciones y Proyectos Industriales MEPI

Nueva 264, Col. El Mirador Ramos Arizpe, Coahuila, México. C.P. 25902 Contact Name: America Amaranta Siller Compian Phone: 844-494-4159

Accreditation is granted to the facility to perform the following calibrations:

Dimensional

Difficisional	T =		
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Outside Micrometer ^{FO}	0.5 mm to 300 mm	$(5.79 \times 10^{-1} + 4 \times 10^{-5}L) \mu m$	Gage Blocks Grade 0 JIS B 7502
Calipers ^{FO}	0.5 mm to 300 mm	$(5.78 + 5 \times 10^{-6} \text{L}) \mu\text{m}$	Gage Blocks Grade 0 JIS B 7507
Height Gage ^{FO}	0.5 mm to 300 mm	$(5.79 \times 10^{-1} + 4 \times 10^{-5}L) \mu m$	Gage Blocks Grade 0 JIS B 7517
Dial Test Indicator ^{FO}	0.001 mm to 1 mm	0.58 μ m	Gage Blocks Grade 0 JIS B 7533
Indicator ^{FO}	0.5 mm to 300 mm	$(5.79 \times 10^{-1} + 4 \times 10^{-5} L) \mu m$	Gage Blocks Grade 0 Granite Plate JIS B 7503 JIS B 7533
Depth Gage ^{FO}	0.5 mm to 300 mm	$(5.79 \times 10^{-1} + 4 \times 10^{-5}L) \mu m$	Gage Blocks Grade 0 JIS B 7518
Thickness Gage ^{FO}	0.5 mm to 300 mm	$(5.79 \times 10^{-1} + 4 \times 10^{-5} L) \mu m$	Gage Blocks Grade 0 JIS B 7503 JIS B 7533
Optical Comparator X Axis Linearity Y Axis Linearity ^o	Up to 200 mm	$(1.4 + 5 \times 10^{-3} \text{L}) \mu\text{m}$	Glass Rule JIS B 7184
Optical Comparator Angularity ^O	0° to 90°	0.003 5°	Angle Blocks Set JIS B 7184
Microscopes X Axis Linearity Y Axis Linearity ^{FO}	Up to 200 mm	$(1.4 + 5 \times 10^{-3} L) \mu m$	Glass Rule JIS B 7153
Rule ^{FO}	0.01 m to 2 m	$(290.67 + 7.94 \times 10^{-4} \text{L}) \mu\text{m}$	Master Rule JIS B 7516
Measuring Tape ^{FO}	0.01 m to 50 m	(578.34 + 1.68 x 10 ⁻³ L) μm	Master Rule JIS B 7512
Pi Tape ^{FO}	Up to 200 in	$(1.46 \times 10^{-3} + 6 \times 10^{-6} \text{L})$ in	Master Rule NIST SOP 23
Protractor Angle Meter ^{FO}	0° to 90°	0.003 5°	Angle Block Set CEM DI-003
Feeler Gage ^{FO}	0.01 mm to 3 mm	0.94 μm	Micrometer JIS B 7524
Pin Gage and Plain Plug Gage ^{FO}	0.2 mm to 25 mm	0.94 μm	Micrometer ASME B 89 1.5
Coating Thickness Gage ^{FO}	23 μm to 1 009 μm	0.21 μm	Coating Thickness Standard Manufacturer's Manual



America Amaranta Siller Compian / Mediciones y Proyectos Industriales MEPI

Nueva 264, Col. El Mirador Ramos Arizpe, Coahuila, México. C.P. 25902 Contact Name: America Amaranta Siller Compian Phone: 844-494-4159

Accreditation is granted to the facility to perform the following calibrations:

Mechanical

IVICOITATITCAT			
MEASURED INSTRUMENT,	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Pressure Gage ^{FO}	3 psi to 300 psi	0.3 psi	Ashcroft Pressure Gage
		_	OIML R 101

Mass, Force and Weighing Devices

iviass, roice and weigh	<u>. C</u>		
MEASURED INSTRUMENT,	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Dynamometers ^{FO}	0.05 kg to 300 kg	$(5.59 \times 10^{-3} + 7 \times 10^{-6} \text{Wt}) \text{ kg}$	Weight set F1, Weight
Force Measurement	0.05 kg to 300 kg	$(5.59 \times 10^{-3} + 7 \times 10^{-6} \text{Wt}) \text{ kg}$	parallelepiped M1
instrument Tensile and			NMX-CH-7500-1-IMNC
Compression ^{FO}			
Balances ^O	1 g to 220 g	$(8.12 \times 10^{-4} + 6 \times 10^{-6} \text{Wt}) \text{ g}$	Weight Set F1
	(Res.= 0.001 g)		Euramet cg-18
	1 g to 1 000 g	$(7.81 \times 10^{-3} + 4 \times 10^{-6} \text{Wt}) \text{ g}$	
	(Res.= 0.01 g)		
	1 g to 5 000 g	$(3.9 \times 10^{-2} + 4 \times 10^{-6} \text{Wt}) \text{ g}$	
	(Res.= 0.05 g)		
Scales ^O	0.01 kg to 10 kg	$(1.63 \times 10^{-3} + 3 \times 10^{-6} \text{Wt}) \text{ kg}$	Weight Set F1
	(Res.= 0.002 kg)		Weight Parallelepiped M1
	0.5 kg to 50 kg	$(8.15 \times 10^{-3} + 3 \times 10^{-6} \text{Wt}) \text{ kg}$	Euramet Cg-18
	(Res.= 0.01 kg)		
	1 kg to 100 kg	$(1.6 \ 3 \ x \ 10^{-2} + 3 \ x \ 10^{-6} \text{Wt}) \ \text{kg}$	
	(Res.= 0.02 kg)		
	100 kg to 300 kg	$(4.07 \times 10^{-2} + 3 \times 10^{-6} \text{Wt}) \text{ kg}$	Weight Parallelepiped M1
	(Res.= 0.05 kg)		Euramet cg-18

Time and Frequency

MEASURED INSTRUMENT,	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Timer Stopwatch ^{FO}	Up to 86 400 s	3.5 s/day	Stopwatch Master
			NIST SP 960-12
Equipment to Output	2 rpm to 99 900 rpm	0.058 rpm	Photo- Tachometer
Angular Velocity Sources,		_	CENAM Technical Guide
Stroboscope, Vortex			
Mixers, Centrifuges,			
Rotarex ^{FO}			



America Amaranta Siller Compian / Mediciones y Proyectos Industriales MEPI

Nueva 264, Col. El Mirador Ramos Arizpe, Coahuila, México. C.P. 25902 Contact Name: America Amaranta Siller Compian Phone: 844-494-4159

Accreditation is granted to the facility to perform the following calibrations:

Optical

opulear			
MEASURED INSTRUMENT,	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Luxmeter ^{FO}	20 lux to 1 800 lux	1.5 % of reading	Luxmeter Master
	1 800 lux to 3 500 lux	2.3 % of reading	CENAM Technical Guide

Electrical

Issue: 06/2022

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Wrist Strap Tester ^F	675 kΩ to 11.5 MΩ	0.68 kΩ	Calibration Unit
Footwear Tester ^F	$675~\mathrm{k}\Omega$ to $120~\mathrm{M}\Omega$	0.68 kΩ	Desco 07010 Manufacturer's Manual
Equipment to Output	-10 mV to 75 mV	0.045 % of reading	Fluke 725
DC Voltage ^{FO}	75 mV to 100 mV	0.047 % of reading	CEM EL-010
	0.1 V to 10 V	0.047 % of reading	
Equipment to Output DC Current ^{FO}	0.1 mA to 24 mA	0.033 % of reading	
Equipment to Output	15 Ω to 400 Ω	0.12 % of reading	
Resistance ^{FO}	401 to 1 500 Ω	0.58 % of reading	
	1 500 Ω to 3 200 Ω	1.2 % of reading	
Equipment to Measure	-10 mV to 75 mV	0.045 % of reading	Fluke 725
DC Voltage ^{FO}	75 mV to 90 mV	0.049 % of reading	Euramet_cg-15
	0.09 V to 20 V	0.035 % of reading	
	20 V to 30 V	0.031 % of reading	
Equipment to Measure	$1~\Omega$ to $400~\Omega$	0.12 % of reading	
Resistance ^{FO}	$401~\Omega$ to $1~500~\Omega$	0.58 % of reading	
	$1~500~\Omega$ to $3~200~\Omega$	1.2 % of reading	
Equipment to Measure DC Current ^{FO}	0.01 mA to 24 mA	0.033 % of reading	Fluke 725 Euramet_cg-15
Equipment to Measure Frequency ^{FO}	1 Hz to 1 000 Hz	0.07 % of reading	
	1 001 Hz to 10 000 Hz	0.058 % of reading	
Equipment to Output	1 Hz to 1 000 Hz	0.058 % of reading	Fluke 725
Frequency ^{FO}	1 001 Hz to 10 000 Hz	0.29 % of reading	CEM EL-010



America Amaranta Siller Compian / Mediciones y Proyectos Industriales MEPI

Nueva 264, Col. El Mirador Ramos Arizpe, Coahuila, México. C.P. 25902 Contact Name: America Amaranta Siller Compian Phone: 844-494-4159

Accreditation is granted to the facility to perform the following calibrations:

Electrical

Issue: 06/2022

Electrical			
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Temperature Calibration,	600 °C to 1 800 °C	1.8 °C	Fluke 725
Indication and Control			Electrical Simulation of
Equipment Used with			Thermocouple Output
Thermocouple Type B ^{FO}			Euramet cg-11
Temperature Calibration,	- 200 °C to 950 °C	0.82 °C	Fluke 725
Indication and Control			Electrical Simulation of
Equipment used with			Thermocouple Output
Thermocouple Type E ^{FO}			Euramet cg-11
Temperature Calibration,	- 200 °C to 1 200 °C	0.82 °C	5
Indication and Control			
Equipment used with			
Thermocouple Type J ^{FO}			
Temperature Calibration,	- 200 °C to 1 370 °C	0.93 °C	
Indication and Control	200 0 10 12 0	0.50	
Equipment used with			
Thermocouple Type K ^{FO}			
Temperature Calibration,	- 200 °C to 900 °C	0.82 °C	
Indication and Control	200 2 10 700 2		
Equipment used with			52
Thermocouple Type L ^{FO}			
Temperature Calibration,	-200 °C to 1 300 °C	1.1 °C	
Indication and Control			
Equipment used with			
Thermocouple Type N ^{FO}			
Temperature Calibration,	-20 °C to 1 750 °C	1.8 °C	
Indication and Control		110 1	
Equipment used with			
Thermocouple Type R ^{FO}			
Temperature Calibration,	-20 °C to 1 750 °C	1.9 °C	
Indication and Control		-	
Equipment used with			
Thermocouple Type S ^{FO}			
Temperature Calibration,	-200 °C to 400 °C	0.93 °C	
Indication and Control			
Equipment used with			
Thermocouple Type T ^{FO}			
Temperature Calibration,	-200 °C to 400 °C	0.87 °C	
Indication and Control			
Equipment used with			
Thermocouple Type U ^{FO}			



America Amaranta Siller Compian / Mediciones y Proyectos Industriales MEPI

Nueva 264, Col. El Mirador Ramos Arizpe, Coahuila, México. C.P. 25902 Contact Name: America Amaranta Siller Compian Phone: 844-494-4159

Accreditation is granted to the facility to perform the following calibrations:

Electrical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Temperature Calibration, Indication and Control Equipment used with RTD Pt 385, 100 Ω ^{FO}	- 200 °C to 800 °C	0.39 °C	Fluke 725 Electrical Simulation of RTD Output Euramet cg-11
Temperature Calibration, Indication and Control Equipment used with RTD Pt 385, 200 Ω^{FO}	- 200 °C to 630 °C	0.24 °C	
Temperature Calibration, Indication and Control Equipment used with RTD Pt 385, 500 Ω^{FO}	- 200 °C to 630 °C	0.36 °C	
Temperature Calibration, Indication and Control Equipment used with RTD Pt 385, 1 000 Ω^{FO}	- 200 °C to 630 °C	0.24 °C	
Temperature Calibration, Indication and Control Equipment used with RTD Ni 672, 120 Ω^{FO}	-80 °C to 260 °C	0.24 °C	

Thermodynamic

Thermodynamic			
MEASURED INSTRUMENT,	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Temperature Measurement	30 °C to 500 °C	1 °C	Fluke 725 with
ThermocoupleFO			RTD Pt100
Type J, K, S			Drywell
Liquid in Glass	30 °C to 500 °C	1 °C	ASTM E220
Thermometer ^{FO}			
Direct reading	30 °C to 500 °C	1 °C	
Thermometer ^{FO}			

1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.

Issue: 06/2022 This supplement is in conjunction with certificate #L22-432-R1





America Amaranta Siller Compian / Mediciones y **Proyectos Industriales MEPI**

Nueva 264, Col. El Mirador Ramos Arizpe, Coahuila, México. C.P. 25902 Contact Name: America Amaranta Siller Compian Phone: 844-494-4159

Accreditation is granted to the facility to perform the following calibrations:

- The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location. Example: Outside Micrometer would mean that the laboratory performs this calibration at its fixed location.
- 4. The presence of a superscript O means that the laboratory performs calibration of the indicated parameter onsite at customer locations. Example: Outside Micrometer^O would mean that the laboratory performs this calibration onsite at the customer's location.
- The presence of a superscript FO means that the laboratory performs calibration of the indicated parameter both at its fixed location and onsite at customer locations. Example: Outside Micrometer^{FO} would mean that the laboratory performs this calibration at its fixed location and onsite at customer locations.
- 6. Measurement uncertainties obtained for calibrations performed at customer sites can be expected to be larger than the measurement uncertainties obtained at the laboratories fixed location for similar calibrations. This is due to the effects of transportation of the standards and equipment and upon environmental conditions at the customer site which are typically not controlled as closely as at the laboratories fixed location.
- The term L represents length in inches or millimeters as appropriate to the uncertainty statement.
- The term Wt represents weight in pounds or grams (including SI multiple and submultiple units) appropriate to the uncertainty statement.